

<IGBT Modules>

# CM75DY-34T

HIGH POWER SWITCHING USE  
INSULATED TYPE



dual switch (half-bridge)

Collector current  $I_C$  ..... **75 A**  
 Collector-emitter voltage  $V_{CES}$  ..... **1700 V**  
 Maximum junction temperature  $T_{vjmax}$  ..... **175 °C**

- Flat base type
- Nickel-plating tab terminals
- RoHS Directive compliant
- UL Recognized under UL1557, File No.E323585

## APPLICATION

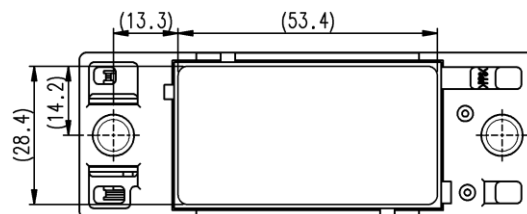
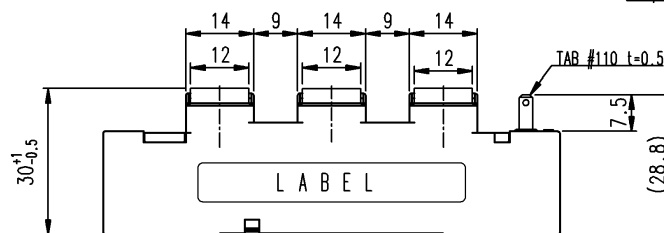
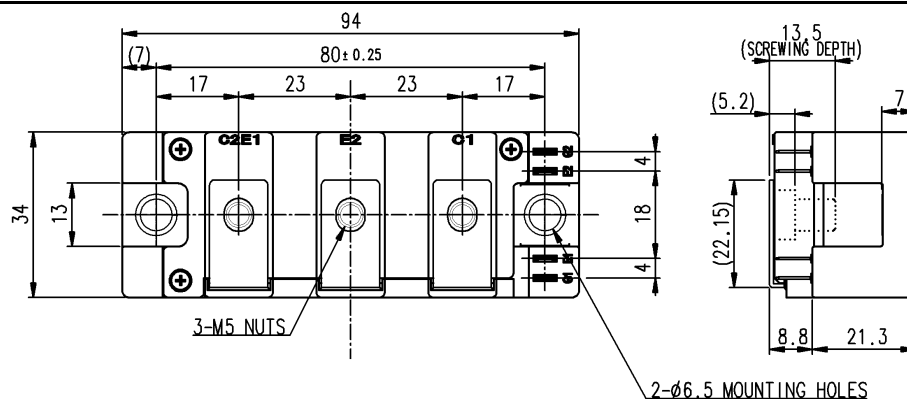
AC Motor Control, Motion/Servo Control, Power supply, etc.

## OPTION (Below options are available.)

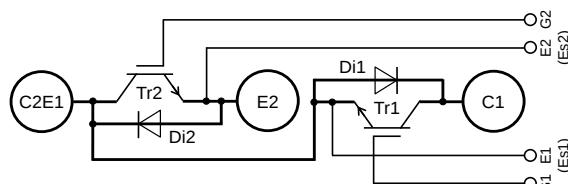
- PC-TIM (Phase Change Thermal Interface Material) pre-apply (Note8)

## OUTLINE DRAWING & INTERNAL CONNECTION

Dimension in mm



INTERNAL CONNECTION



Tolerance otherwise specified

| Division of Dimension | Tolerance |
|-----------------------|-----------|
| 0.5 to 3              | ±0.2      |
| over 3 to 6           | ±0.3      |
| over 6 to 30          | ±0.5      |
| over 30 to 120        | ±0.8      |
| over 120 to 400       | ±1.2      |

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**CM75DY-34T**

HIGH POWER SWITCHING USE  
INSULATED TYPE

**MAXIMUM RATINGS (T<sub>vj</sub>=25 °C, unless otherwise specified)**

| Symbol                   | Item                           | Conditions                                      | Rating      | Unit |
|--------------------------|--------------------------------|-------------------------------------------------|-------------|------|
| V <sub>CES</sub>         | Collector-emitter voltage      | G-E short-circuited                             | 1700        | V    |
| V <sub>GES</sub>         | Gate-emitter voltage           | C-E short-circuited                             | ± 20        | V    |
| I <sub>C</sub>           | Collector current              | DC, T <sub>C</sub> =137 °C* (Note2, 4)          | 75          | A    |
| I <sub>CRM</sub>         |                                | Pulse, Repetitive (Note3)                       | 150         |      |
| P <sub>tot</sub>         | Total power dissipation        | T <sub>C</sub> =25 °C (Note2, 4)                | 930         | W    |
| I <sub>E</sub> (Note1)   | Emitter current                | DC (Note2)                                      | 75          | A    |
| I <sub>ERM</sub> (Note1) |                                | Pulse, Repetitive (Note3)                       | 150         |      |
| V <sub>isol</sub>        | Isolation voltage              | Terminals to base plate, RMS, f=60 Hz, AC 1 min | 4000        | V    |
| T <sub>vjmax</sub>       | Maximum junction temperature   | Instantaneous event (overload) (Note8)          | 175         | °C   |
| T <sub>Cmax</sub>        | Maximum case temperature       | (Note4,8)                                       | 150*        |      |
| T <sub>vjop</sub>        | Operating junction temperature | Continuous operation (under switching) (Note8)  | -40 ~ +150  | °C   |
| T <sub>stg</sub>         | Storage temperature            | -                                               | -40 ~ +150* |      |

**ELECTRICAL CHARACTERISTICS (T<sub>vj</sub>=25 °C, unless otherwise specified)**

| Symbol                                 | Item                                 | Conditions                                                                                                                                                |                         | Limits |      |      | Unit |
|----------------------------------------|--------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------------|--------|------|------|------|
|                                        |                                      |                                                                                                                                                           |                         | Min.   | Typ. | Max. |      |
| I <sub>CES</sub>                       | Collector-emitter cut-off current    | V <sub>CE</sub> =V <sub>CES</sub> , G-E short-circuited                                                                                                   |                         | -      | -    | 1.0  | mA   |
| I <sub>GES</sub>                       | Gate-emitter leakage current         | V <sub>GE</sub> =V <sub>GES</sub> , C-E short-circuited                                                                                                   |                         | -      | -    | 0.5  | μA   |
| V <sub>GE(th)</sub>                    | Gate-emitter threshold voltage       | I <sub>C</sub> =7.5 mA, V <sub>CE</sub> =10 V                                                                                                             |                         | 5.4    | 6.0  | 6.6  | V    |
| V <sub>CESat</sub><br>(Terminal)       | Collector-emitter saturation voltage | I <sub>C</sub> =75 A, V <sub>GE</sub> =15 V,<br>Refer to the figure of test circuit<br>(Note5)                                                            | T <sub>vj</sub> =25 °C  | -      | 2.0  | 2.45 | V    |
|                                        |                                      |                                                                                                                                                           | T <sub>vj</sub> =125 °C | -      | 2.4  | -    |      |
|                                        |                                      |                                                                                                                                                           | T <sub>vj</sub> =150 °C | -      | 2.5  | -    |      |
| V <sub>CESat</sub><br>(Chip)           | Collector-emitter saturation voltage | I <sub>C</sub> =75 A,<br>V <sub>GE</sub> =15 V,<br>(Note5)                                                                                                | T <sub>vj</sub> =25 °C  | -      | 1.95 | 2.35 | V    |
|                                        |                                      |                                                                                                                                                           | T <sub>vj</sub> =125 °C | -      | 2.35 | -    |      |
|                                        |                                      |                                                                                                                                                           | T <sub>vj</sub> =150 °C | -      | 2.45 | -    |      |
| C <sub>ies</sub>                       | Input capacitance                    | V <sub>CE</sub> =10 V, G-E short-circuited                                                                                                                |                         | -      | -    | 20.6 | nF   |
| C <sub>oes</sub>                       | Output capacitance                   |                                                                                                                                                           |                         | -      | -    | 0.5  |      |
| C <sub>res</sub>                       | Reverse transfer capacitance         |                                                                                                                                                           |                         | -      | -    | 0.2  |      |
| Q <sub>G</sub>                         | Gate charge                          | V <sub>CC</sub> =1000 V, I <sub>C</sub> =75 A, V <sub>GE</sub> =15 V                                                                                      |                         | -      | 0.62 | -    | μC   |
| t <sub>d(on)</sub>                     | Turn-on delay time                   | V <sub>CC</sub> =1000 V, I <sub>C</sub> =75 A, V <sub>GE</sub> =±15 V,<br>R <sub>G</sub> =0 Ω, Inductive load                                             |                         | -      | -    | 800  | ns   |
| t <sub>r</sub>                         | Rise time                            |                                                                                                                                                           |                         | -      | -    | 200  |      |
| t <sub>d(off)</sub>                    | Turn-off delay time                  |                                                                                                                                                           |                         | -      | -    | 800  |      |
| t <sub>f</sub>                         | Fall time                            |                                                                                                                                                           |                         | -      | -    | 600  |      |
| V <sub>EC</sub> (Note.1)<br>(Terminal) | Emitter-collector voltage            | I <sub>E</sub> =75 A, G-E short-circuited,<br>Refer to the figure of test circuit<br>(Note5)                                                              | T <sub>vj</sub> =25 °C  | -      | 2.7  | 3.3  | V    |
|                                        |                                      |                                                                                                                                                           | T <sub>vj</sub> =125 °C | -      | 2.9  | -    |      |
|                                        |                                      |                                                                                                                                                           | T <sub>vj</sub> =150 °C | -      | 2.9  | -    |      |
| V <sub>EC</sub> (Note.1)<br>(Chip)     | Emitter-collector voltage            | I <sub>E</sub> =75 A,<br>G-E short-circuited,<br>(Note5)                                                                                                  | T <sub>vj</sub> =25 °C  | -      | 2.65 | 3.20 | V    |
|                                        |                                      |                                                                                                                                                           | T <sub>vj</sub> =125 °C | -      | 2.75 | -    |      |
|                                        |                                      |                                                                                                                                                           | T <sub>vj</sub> =150 °C | -      | 2.75 | -    |      |
| t <sub>rr</sub> (Note1)                | Reverse recovery time                | V <sub>CC</sub> =1000 V, I <sub>E</sub> =75 A, V <sub>GE</sub> =±15 V,<br>R <sub>G</sub> =0 Ω, Inductive load                                             |                         | -      | -    | 300  | ns   |
| Q <sub>rr</sub> (Note1)                | Reverse recovery charge              | R <sub>G</sub> =0 Ω, Inductive load                                                                                                                       |                         | -      | 3.8  | -    | μC   |
| E <sub>on</sub>                        | Turn-on switching energy per pulse   | V <sub>CC</sub> =1000 V, I <sub>C</sub> =I <sub>E</sub> =75 A,<br>V <sub>GE</sub> =±15 V, R <sub>G</sub> =0 Ω, T <sub>vj</sub> =150 °C,<br>Inductive load |                         | -      | 22   | -    | mJ   |
| E <sub>off</sub>                       | Turn-off switching energy per pulse  |                                                                                                                                                           |                         | -      | 21   | -    |      |
| E <sub>rr</sub> (Note1)                | Reverse recovery energy per pulse    | Inductive load                                                                                                                                            |                         | -      | 8.57 | -    | mJ   |
| R <sub>CC'+EE'</sub>                   | Internal lead resistance             | Main terminals-chip, per switch, T <sub>C</sub> =25 °C (Note4)                                                                                            |                         | -      | 0.2  | -    | mΩ   |
| r <sub>g</sub>                         | Internal gate resistance             | Per switch                                                                                                                                                |                         | -      | 10   | -    | Ω    |

\*: The value of PC-TIM applied module is limited by the heat resistant temperature of PC-TIM.

## THERMAL RESISTANCE CHARACTERISTICS

| Symbol         | Item                       | Conditions                                                            | Limits |      |      | Unit |
|----------------|----------------------------|-----------------------------------------------------------------------|--------|------|------|------|
|                |                            |                                                                       | Min.   | Typ. | Max. |      |
| $R_{th(j-c)Q}$ | Thermal resistance         | Junction to case, per Inverter IGBT (Note4)                           | -      | -    | 161  | K/kW |
| $R_{th(j-c)D}$ |                            | Junction to case, per Inverter FWD (Note4)                            | -      | -    | 231  |      |
| $R_{th(c-s)}$  | Contact thermal resistance | Case to heat sink, per 1 module<br>Thermal grease applied (Note4,6,8) | -      | 36.6 | -    | K/kW |

## MECHANICAL CHARACTERISTICS

| Symbol | Item                   | Conditions                      | Limits |      |      | Unit |
|--------|------------------------|---------------------------------|--------|------|------|------|
|        |                        |                                 | Min.   | Typ. | Max. |      |
| $M_t$  | Mounting torque        | Main terminals M 5 screw        | 2.5    | 3.0  | 3.5  | N·m  |
| $M_s$  | Mounting torque        | Mounting to heat sink M 6 screw | 3.5    | 4.0  | 4.5  | N·m  |
| $d_s$  | Creepage distance      | Terminal to terminal            | 18.4   | -    | -    | mm   |
|        |                        | Terminal to base plate          | 21.1   | -    | -    |      |
| $d_a$  | Clearance              | Terminal to terminal            | 9.6    | -    | -    | mm   |
|        |                        | Terminal to base plate          | 16.7   | -    | -    |      |
| $e_c$  | Flatness of base plate | On the centerline X, Y (Note7)  | ±0     | -    | +200 | μm   |
| m      | mass                   | -                               | -      | 120  | -    | g    |

\*. This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU and (EU) 2015/863.

Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (FWD).

2. Junction temperature ( $T_{vj}$ ) should not increase beyond  $T_{vjmax}$  rating.

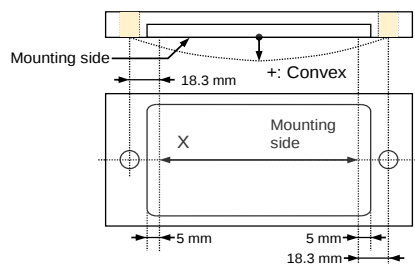
3. Pulse width and repetition rate should be such that the device junction temperature ( $T_{vj}$ ) does not exceed  $T_{vjmax}$  rating.

4. Case temperature ( $T_c$ ) and heat sink temperature ( $T_s$ ) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.

5. Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.

6. Typical value is measured by using thermally conductive grease of  $\lambda=3.0W/(m\cdot K)/D_{(C-S)}=50\mu m$ .

7. The base plate (mounting side) flatness measurement points (X, Y) are shown in the following figure.



8. Long term performance related to thermal conductive grease and PC-TIM (including but not limited to aspects such as the increase of thermal resistance due to pumping out, etc.) should be verified under your specific application conditions. Each temperature condition ( $T_{vjmax}$ ,  $T_{vjop}$ ,  $T_{cmax}$ ) must be maintained below the maximum rated temperature throughout consideration of the temperature rise even for long term usage.

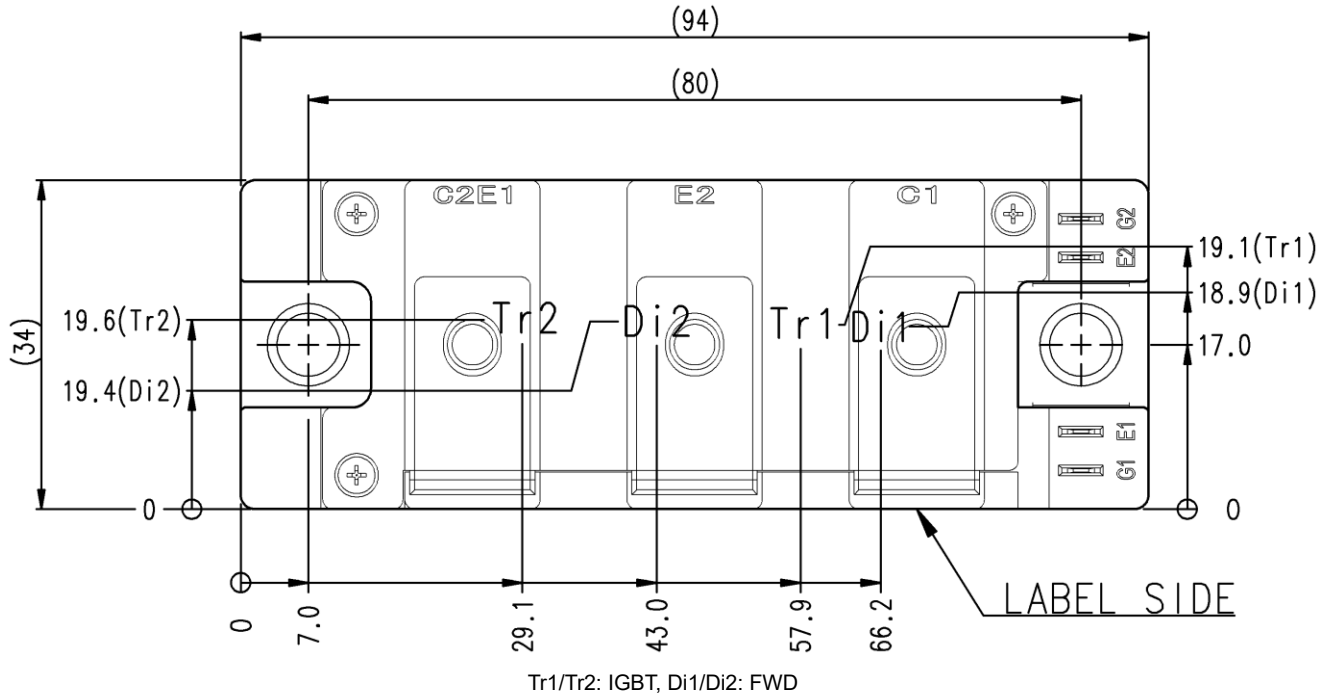
<IGBT Modules>  
**CM75DY-34T**  
HIGH POWER SWITCHING USE  
INSULATED TYPE

**RECMENDED OPERATING CONDITIONS**

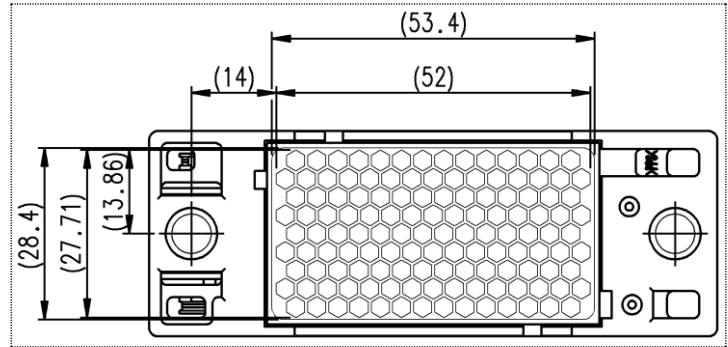
| Symbol     | Item                          | Conditions                             | Limits |      |      | Unit     |
|------------|-------------------------------|----------------------------------------|--------|------|------|----------|
|            |                               |                                        | Min.   | Typ. | Max. |          |
| $V_{CC}$   | (DC) Supply voltage           | Applied across C1-E2 terminals         | -      | 1000 | 1200 | V        |
| $V_{GEon}$ | Gate (-emitter drive) voltage | Applied across G1-Es1/G2-Es2 terminals | 13.5   | 15.0 | 16.5 | V        |
| $R_G$      | External gate resistance      | Per switch                             | 0      | -    | 91   | $\Omega$ |

**CHIP LOCATION (Top view)**

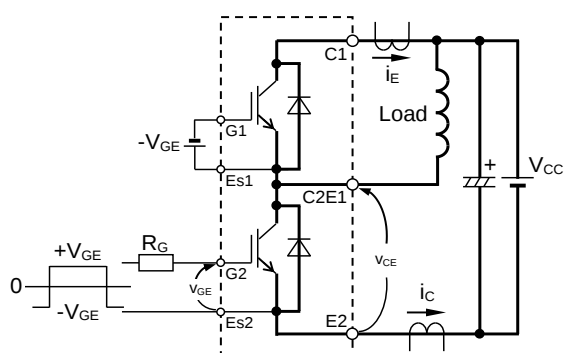
Dimension in mm, tolerance:  $\pm 1$  mm



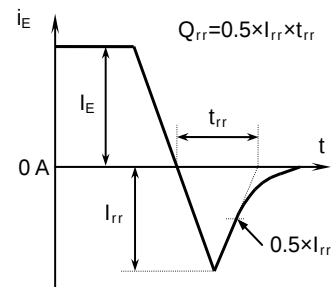
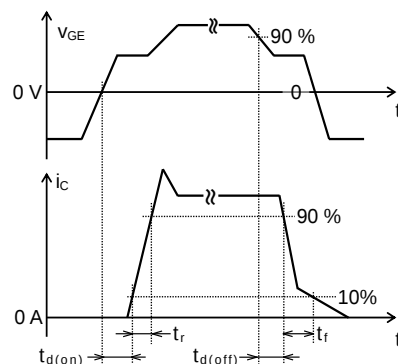
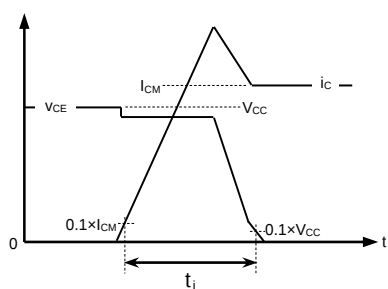
**Option: PC-TIM applied baseplate outline**



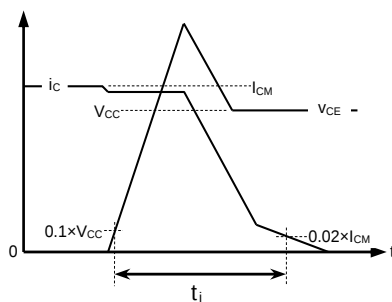
## TEST CIRCUIT AND WAVEFORMS



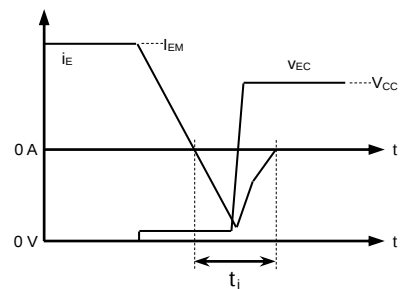
Switching characteristics test circuit and waveforms

 $t_{rr}$ ,  $Q_{rr}$  characteristics test waveform

IGBT Turn-on switching energy



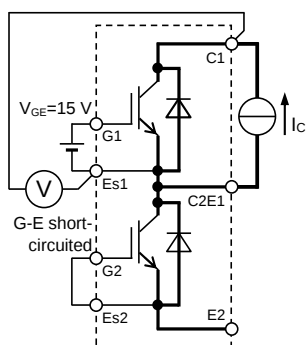
IGBT Turn-off switching energy



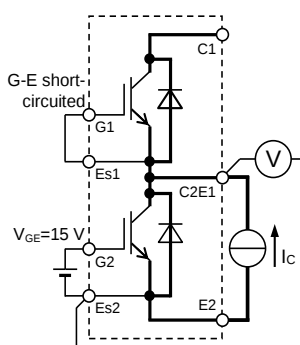
FWD Reverse recovery energy

Turn-on / Turn-off switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

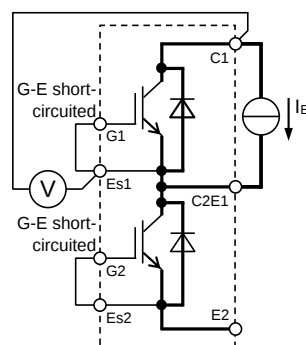
## TEST CIRCUIT



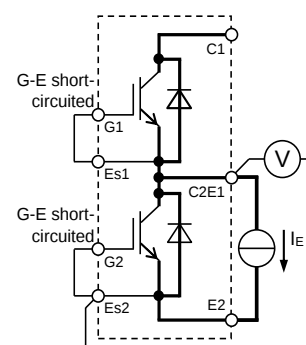
Tr1

 $V_{CEsat}$  characteristics test circuit

Tr2



Di1

 $V_{EC}$  characteristics test circuit

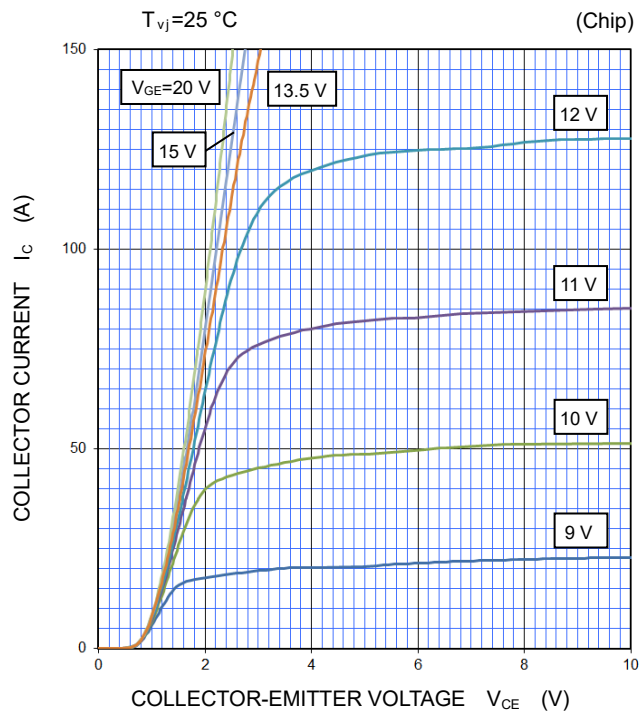
Di2

**CM75DY-34T**

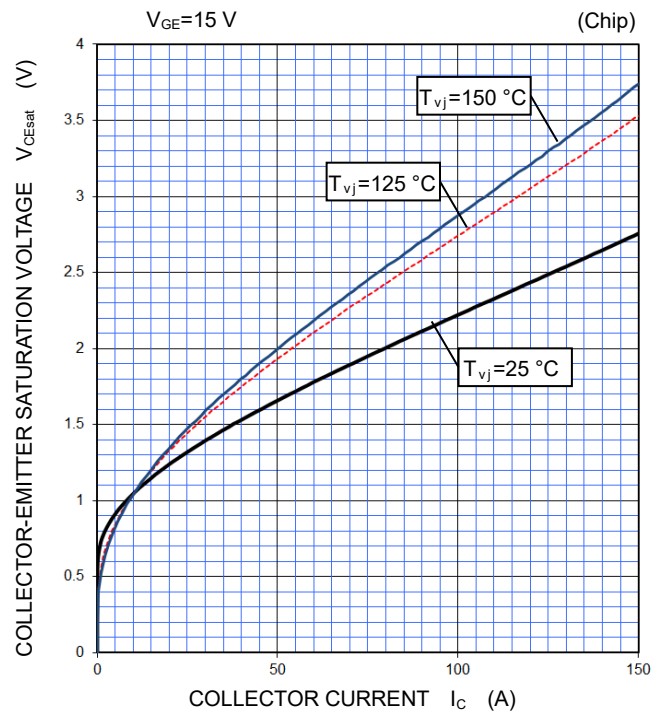
HIGH POWER SWITCHING USE  
INSULATED TYPE

**PERFORMANCE CURVES**

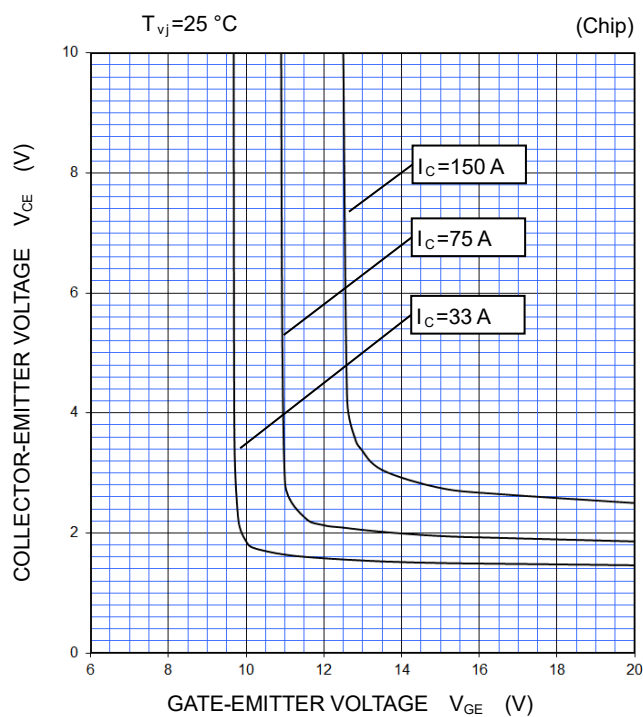
**OUTPUT CHARACTERISTICS  
(TYPICAL)**



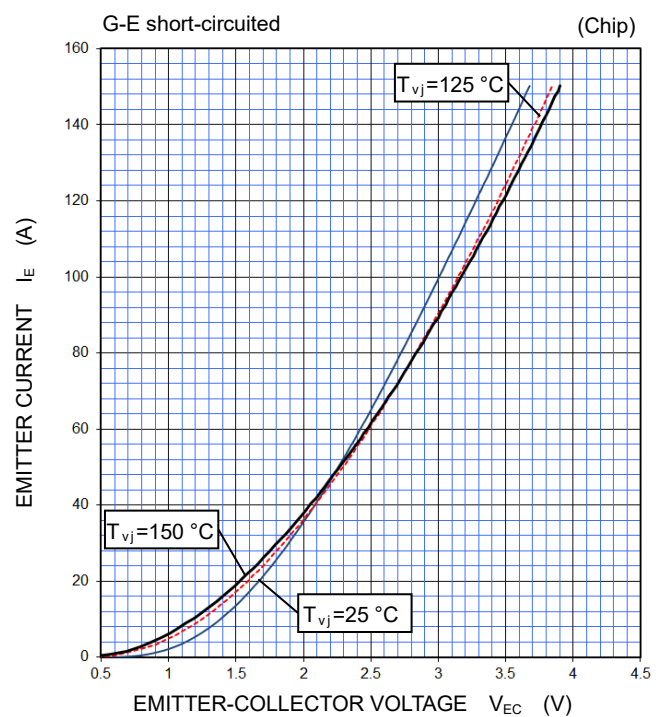
**COLLECTOR-EMITTER SATURATION VOLTAGE  
CHARACTERISTICS  
(TYPICAL)**



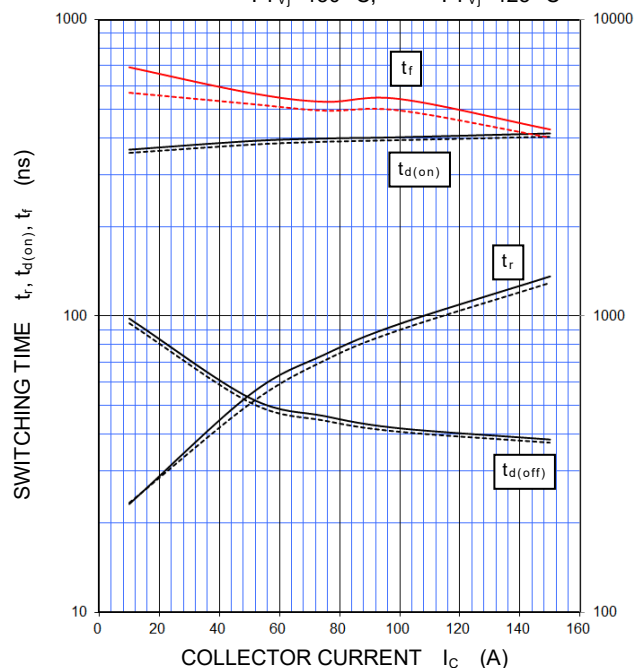
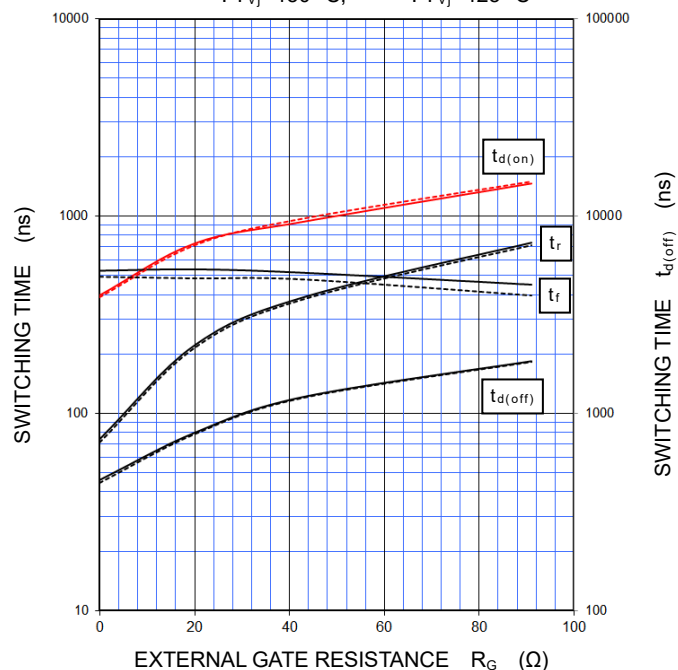
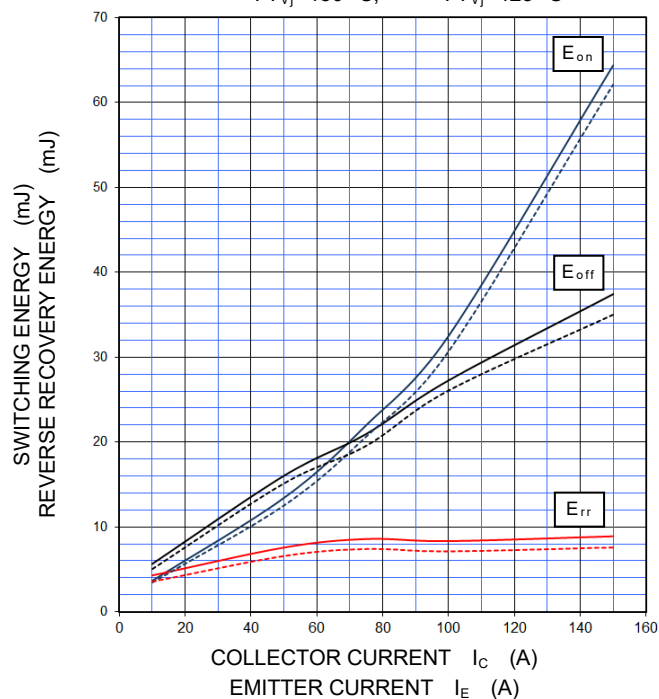
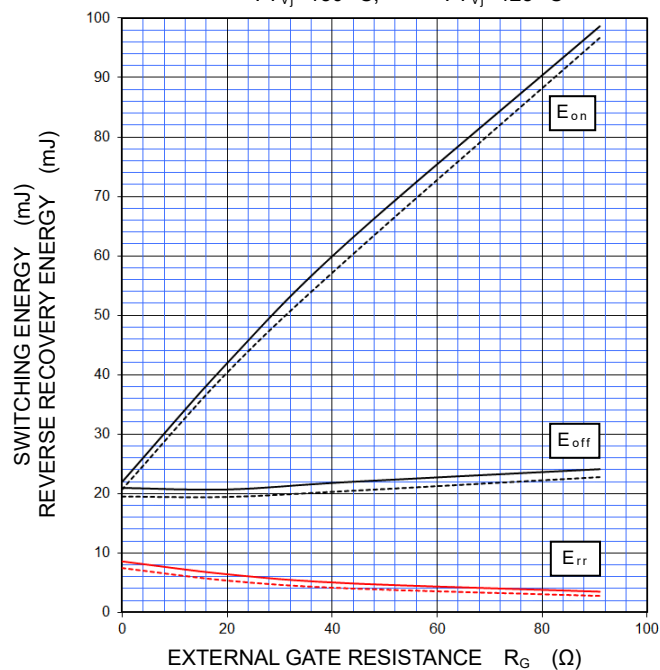
**COLLECTOR-EMITTER VOLTAGE CHARACTERISTICS  
(TYPICAL)**



**FREE WHEELING DIODE  
FORWARD CHARACTERISTICS  
(TYPICAL)**



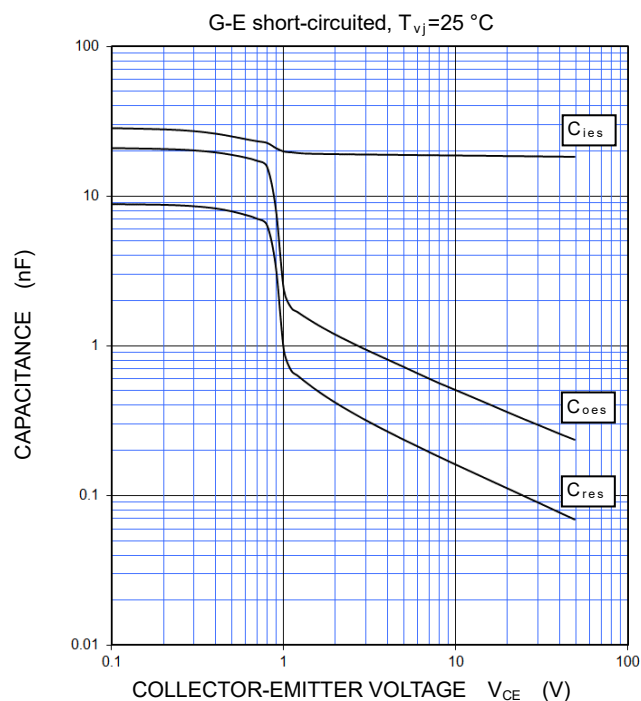
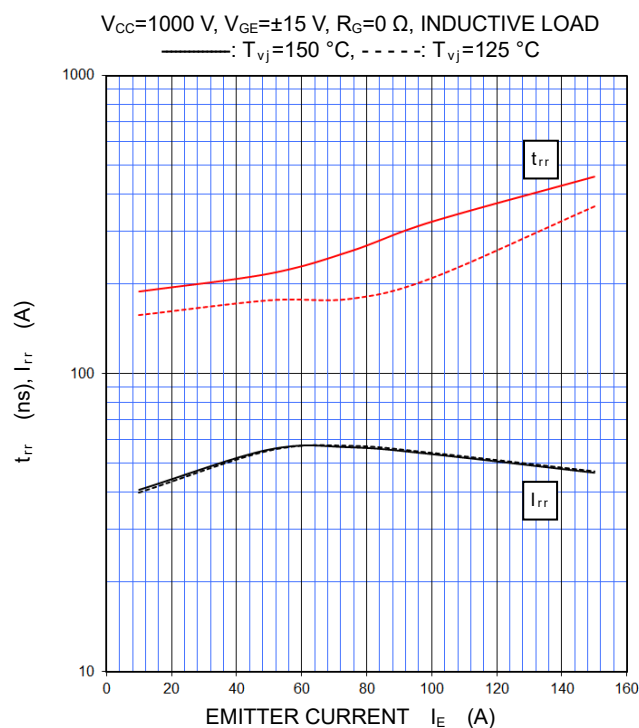
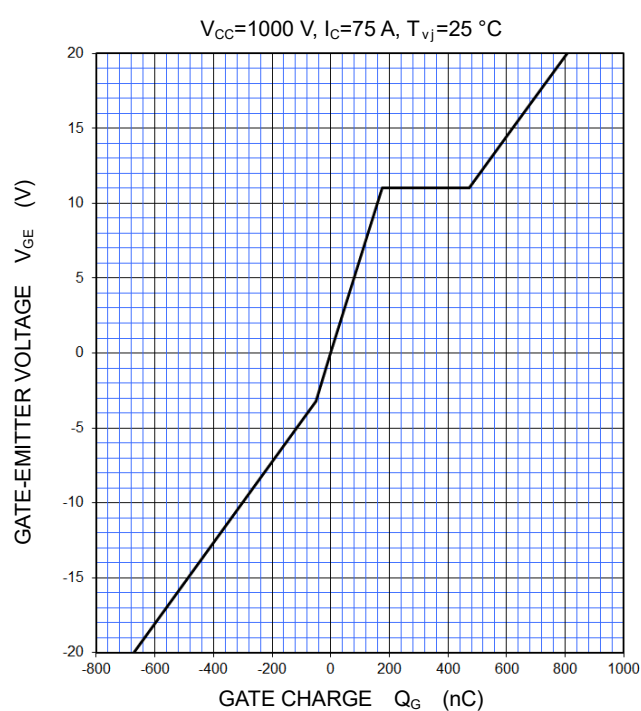
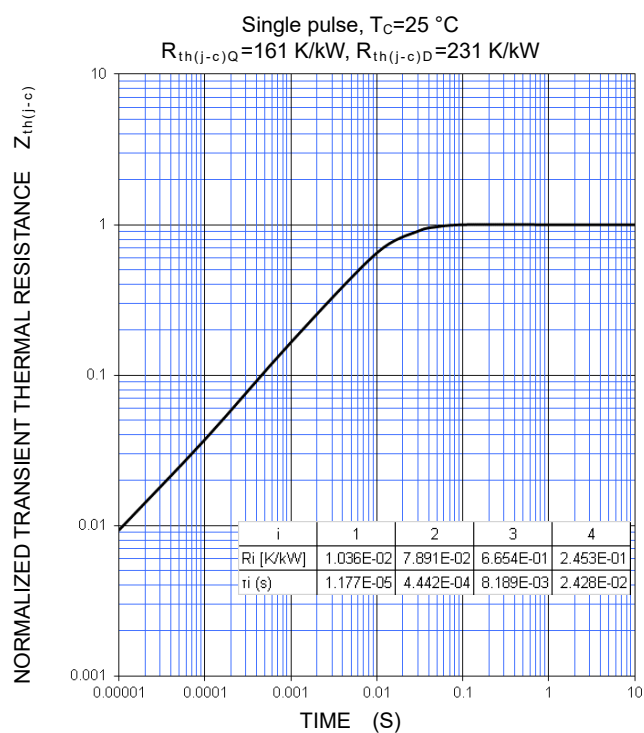
## PERFORMANCE CURVES

HALF-BRIDGE SWITCHING CHARACTERISTICS  
(TYPICAL)
 $V_{CC}=1000\text{ V}$ ,  $V_{GE}=\pm 15\text{ V}$ ,  $R_G=0\ \Omega$ , INDUCTIVE LOAD  
 —:  $T_{vj}=150\text{ }^{\circ}\text{C}$ , - - - -:  $T_{vj}=125\text{ }^{\circ}\text{C}$ 
HALF-BRIDGE SWITCHING CHARACTERISTICS  
(TYPICAL)
 $V_{CC}=1000\text{ V}$ ,  $V_{GE}=\pm 15\text{ V}$ ,  $I_C=75\text{ A}$ , INDUCTIVE LOAD  
 —:  $T_{vj}=150\text{ }^{\circ}\text{C}$ , - - - -:  $T_{vj}=125\text{ }^{\circ}\text{C}$ 
HALF-BRIDGE SWITCHING CHARACTERISTICS  
(TYPICAL)
 $V_{CC}=1000\text{ V}$ ,  $V_{GE}=\pm 15\text{ V}$ ,  $R_G=0\ \Omega$ , INDUCTIVE LOAD  
 —:  $T_{vj}=150\text{ }^{\circ}\text{C}$ , - - - -:  $T_{vj}=125\text{ }^{\circ}\text{C}$ 
HALF-BRIDGE SWITCHING CHARACTERISTICS  
(TYPICAL)
 $V_{CC}=1000\text{ V}$ ,  $V_{GE}=\pm 15\text{ V}$ ,  $I_C=75\text{ A}$ , INDUCTIVE LOAD  
 —:  $T_{vj}=150\text{ }^{\circ}\text{C}$ , - - - -:  $T_{vj}=125\text{ }^{\circ}\text{C}$ 


**CM75DY-34T**

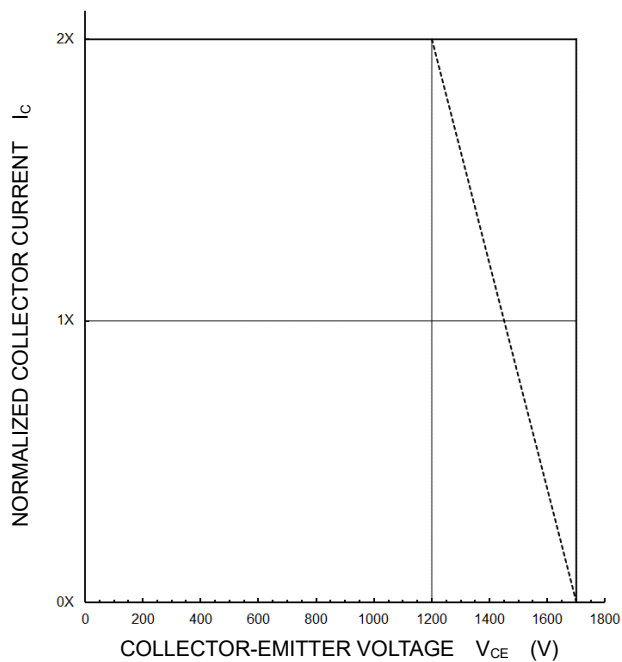
HIGH POWER SWITCHING USE

INSULATED TYPE

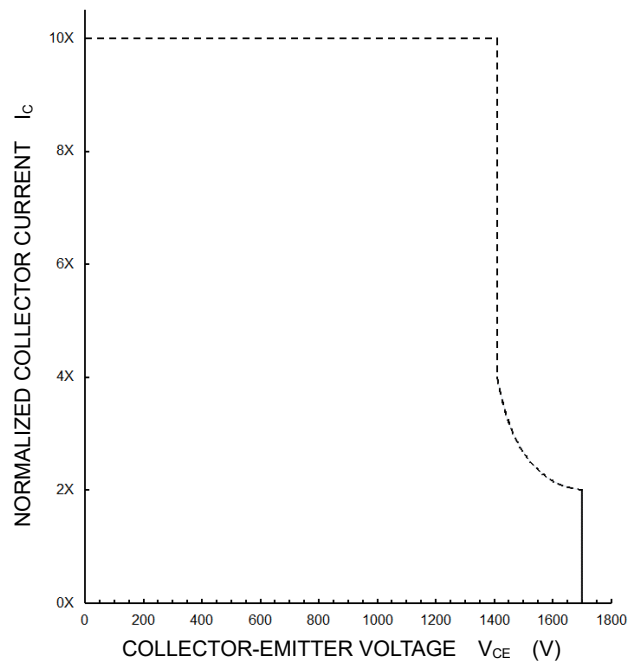
**PERFORMANCE CURVES****CAPACITANCE CHARACTERISTICS  
(TYPICAL)****FREE WHEELING DIODE  
REVERSE RECOVERY CHARACTERISTICS  
(TYPICAL)****GATE CHARGE CHARACTERISTICS  
(TYPICAL)****TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS  
(MAXIMUM)**

**CM75DY-34T**HIGH POWER SWITCHING USE  
INSULATED TYPE**PERFORMANCE CURVES****TURN-OFF SWITCHING SAFE OPERATING AREA  
(REVERSE BIAS SAFE OPERATING AREA)  
(MAXIMUM)**

$V_{CC} \leq 1200 \text{ V}$ ,  $V_{GE} = \pm 15 \text{ V}$ ,  $R_G = 0 \sim 91 \Omega$ ,  
 —:  $T_{vj} = 25 \sim 150 \text{ }^\circ\text{C}$  (Normal load operations (Continuous))  
 - - - - -:  $T_{vj} = 175 \text{ }^\circ\text{C}$  (Unusual load operations (Limited period))

**SHORT-CIRCUIT SAFE OPERATING AREA  
(MAXIMUM)**

$V_{CC} \leq 1200 \text{ V}$ ,  $V_{GE} = \pm 15 \text{ V}$ ,  $R_G = 0 \sim 91 \Omega$ ,  
 $T_{vj} = 25 \sim 150 \text{ }^\circ\text{C}$ ,  $t_W \leq 8 \mu\text{s}$ , Non-Repetitive



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

### **Important Notice**

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